

Search Notes

Application/Control No.

10/672,943

Examiner

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Applicant(s)/Patent under
Reexamination

NUNEZ, CHRIS

Art Unit

2165

SEARCHED

Class	Subclass	Date	Examiner
707	1-10, 100-104.1 200-206	6/6/2006	YW
715,	515-517	6/6/2006	YW
715	501	6/6/2006	YW
711	137	6/6/2006	YW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor search (double patenting) uspto uspgpub epo jpo ibmtech derwent	6/6/2006	YW
acm ieee citeseer internet Search strategy attached	6/6/2006	YW